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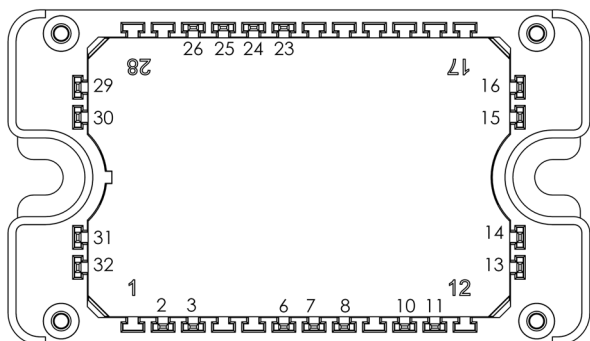
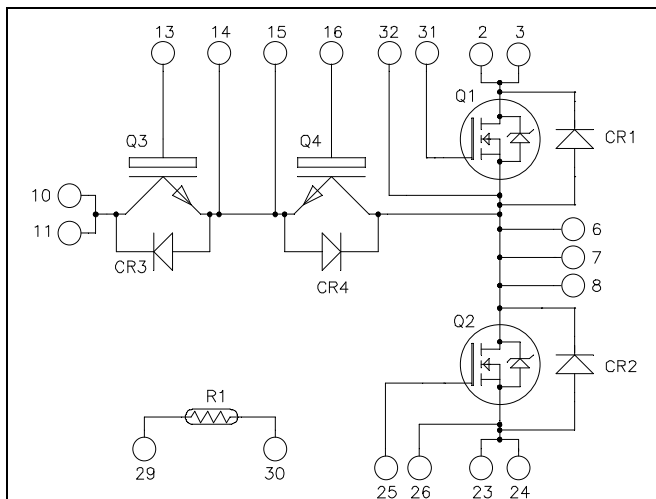
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Phase Leg & Dual Common Emitter Power Module



All multiple inputs and outputs must be shorted together
10/11 ; 23/24 ; 2/3 ; ...

SiC MOSFET (Q1, Q2):

$V_{CES} = 1200V$; $R_{DS(on)} = 34m\Omega$ max @ $T_j = 25^\circ C$

Trench & Field Stop IGBT3 (Q3, Q4):

$V_{CES} = 600V$; $I_C = 50A$ @ $T_c = 100^\circ C$

Application

- Solar converter
- Uninterruptible Power Supplies

Features

- **Q1, Q2 SiC Power MOSFET**
 - Low $R_{DS(on)}$
 - High temperature performance
- **Q3, Q4 Trench + field Stop IGBT3**
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 20 kHz
- **SiC Schottky Diode (CR1 to CR4)**
 - Zero reverse recovery
 - Zero forward recovery
 - Temperature Independent switching behavior
 - Positive temperature coefficient on VF
- Kelvin emitter for easy drive
- Very low stray inductance
- AlN substrate for improved thermal performance
- Internal thermistor for temperature monitoring

Benefits

- Stable temperature behavior
- Very rugged
- Solderable terminals for easy PCB mounting
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T_C of V_{CESat}
- Low profile

All ratings @ $T_j = 25^\circ C$ unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.
See application note APT0502 on www.microsemi.com

1. SiC MOSFET characteristics (Per MOSFET)

Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V_{DS}	Drain - Source Voltage	1200	V
I_D	Continuous Drain Current	$T_c = 25^\circ\text{C}$	A
		$T_c = 80^\circ\text{C}$	
I_{DM}	Pulsed Drain Current	140	
V_{GS}	Gate - Source Voltage	-10/+25	V
$R_{DS(on)}$	Drain - Source ON Resistance	34	m Ω
P_D	Power Dissipation	$T_c = 25^\circ\text{C}$	W

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V$, $V_{DS} = 1200V$			100	μA
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 20V$ $I_D = 50A$	$T_j = 25^\circ\text{C}$	25	34	m Ω
			$T_j = 150^\circ\text{C}$	43		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 12.5mA$	2.4	3		V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = 20V$, $V_{DS} = 0V$			600	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 1000V$ $f = 1MHz$		2788		pF
C_{oss}	Output Capacitance			220		
C_{rss}	Reverse Transfer Capacitance			15		
Q_g	Total gate Charge	$V_{GS} = -5/20V$ $V_{Bus} = 800V$ $I_D = 50A$		161		nC
Q_{gs}	Gate – Source Charge			46		
Q_{gd}	Gate – Drain Charge			50		
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = -2/+20V$ $V_{Bus} = 800V$ $I_D = 50A$ $R_L = 16\Omega$; $R_G = 20\Omega$		21		ns
T_r	Rise Time			19		
$T_{d(off)}$	Turn-off Delay Time			50		
T_f	Fall Time			30		
E_{on}	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$ $I_D = 50A$ $R_G = 20\Omega$	$T_j = 150^\circ\text{C}$	1.1		mJ
E_{off}	Turn off Energy			0.6		
R_{thJC}	Junction to Case Thermal Resistance				0.4	$^\circ\text{C/W}$

SiC diode ratings and characteristics (CR1 & CR2) (per diode)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V_{RRM}	Peak Repetitive Reverse Voltage				1200	V
I_{RM}	Reverse Leakage Current	$V_R = 1200V$	$T_j = 25^\circ C$	10	200	μA
			$T_j = 175^\circ C$	500		
I_F	DC Forward Current		$T_c = 100^\circ C$	10		A
V_F	Diode Forward Voltage	$I_F = 10A$	$T_j = 25^\circ C$	1.5	1.8	V
			$T_j = 175^\circ C$	2.3		
Q_C	Total Capacitive Charge	$I_F = 10A, V_R = 600V$ $di/dt = 500A/\mu s$		120		nC
C	Total Capacitance	$f = 1MHz, V_R = 200V$		115		pF
		$f = 1MHz, V_R = 400V$		85		
R_{thJC}	Junction to Case Thermal Resistance				1.1	$^\circ C/W$

2. Trench & Field Stop IGBT3 (per IGBT)
Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V_{CES}	Collector - Emitter Voltage	600	V
I_C	Continuous Collector Current	$T_C = 25^\circ C$ $T_C = 100^\circ C$	105 50
I_{CM}	Pulsed Collector Current	$T_C = 25^\circ C$	100
V_{GE}	Gate – Emitter Voltage	± 20	V
P_D	Power Dissipation	$T_C = 25^\circ C$	176
RBSOA	Reverse Bias Safe Operating Area	$T_j = 150^\circ C$	100A @ 550V

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I_{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 600V$			25	μA
$V_{CE(sat)}$	Collector Emitter Saturation Voltage	$V_{GE} = 15V$ $I_C = 50A$	$T_j = 25^\circ C$ $T_j = 150^\circ C$	1.5 1.7	1.9	V
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 600\mu A$	5.0	5.8	6.5	V
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$			600	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C _{ies}	Input Capacitance	V _{GE} = 0V V _{CE} = 25V f = 1MHz		3150		pF
C _{oes}	Output Capacitance			200		
C _{res}	Reverse Transfer Capacitance			95		
Q _G	Gate charge	V _{GE} = ±15V, I _C = 50A V _{CE} = 300V		500		nC
T _{d(on)}	Turn-on Delay Time	Inductive Switching (25°C) V _{GE} = ±15V V _{Bus} = 300V I _C = 50A R _G = 8.2Ω		110		ns
T _r	Rise Time			45		
T _{d(off)}	Turn-off Delay Time			200		
T _f	Fall Time			40		
T _{d(on)}	Turn-on Delay Time	Inductive Switching (150°C) V _{GE} = ±15V V _{Bus} = 300V I _C = 50A R _G = 8.2Ω		120		ns
T _r	Rise Time			50		
T _{d(off)}	Turn-off Delay Time			250		
T _f	Fall Time			60		
E _{on}	Turn-on Switching Energy	V _{GE} = ±15V V _{Bus} = 300V I _C = 50A R _G = 8.2Ω	T _j = 25°C	0.2		mJ
			T _j = 150°C	0.26		
E _{off}	Turn-off Switching Energy	I _C = 50A R _G = 8.2Ω	T _j = 25°C	1.35		mJ
			T _j = 150°C	1.75		
I _{sc}	Short Circuit data	V _{GE} ≤ 15V ; V _{Bus} = 360V t _p ≤ 10μs ; T _j = 150°C		250		A
R _{thJC}	Junction to Case Thermal Resistance				0.68	°C/W

3. SiC diode ratings and characteristics (CR3 & CR4) (per diode)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V _{RRM}	Peak Repetitive Reverse Voltage				600	V
I _{RM}	Reverse Leakage Current	V _R = 600V	T _j = 25°C	20	120	μA
			T _j = 175°C	40	600	
I _F	DC Forward Current		T _c = 100°C	20		A
V _F	Diode Forward Voltage	I _F = 20A	T _j = 25°C	1.6	1.8	V
			T _j = 175°C	2	2.4	
Q _C	Total Capacitive Charge	I _F = 20A, V _R = 600V di/dt = 800A/μs		56		nC
C	Total Capacitance	f = 1MHz, V _R = 200V		130		pF
		f = 1MHz, V _R = 400V		100		
R _{thJC}	Junction to Case Thermal Resistance				1.1	°C/W

4. Temperature sensor NTC

Symbol	Characteristic	Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C		22		kΩ
ΔR ₂₅ /R ₂₅	Resistance tolerance			5	%
ΔB/B	Beta tolerance			3	
B _{25/100}	T ₂₅ = 298.16 K		3980		K

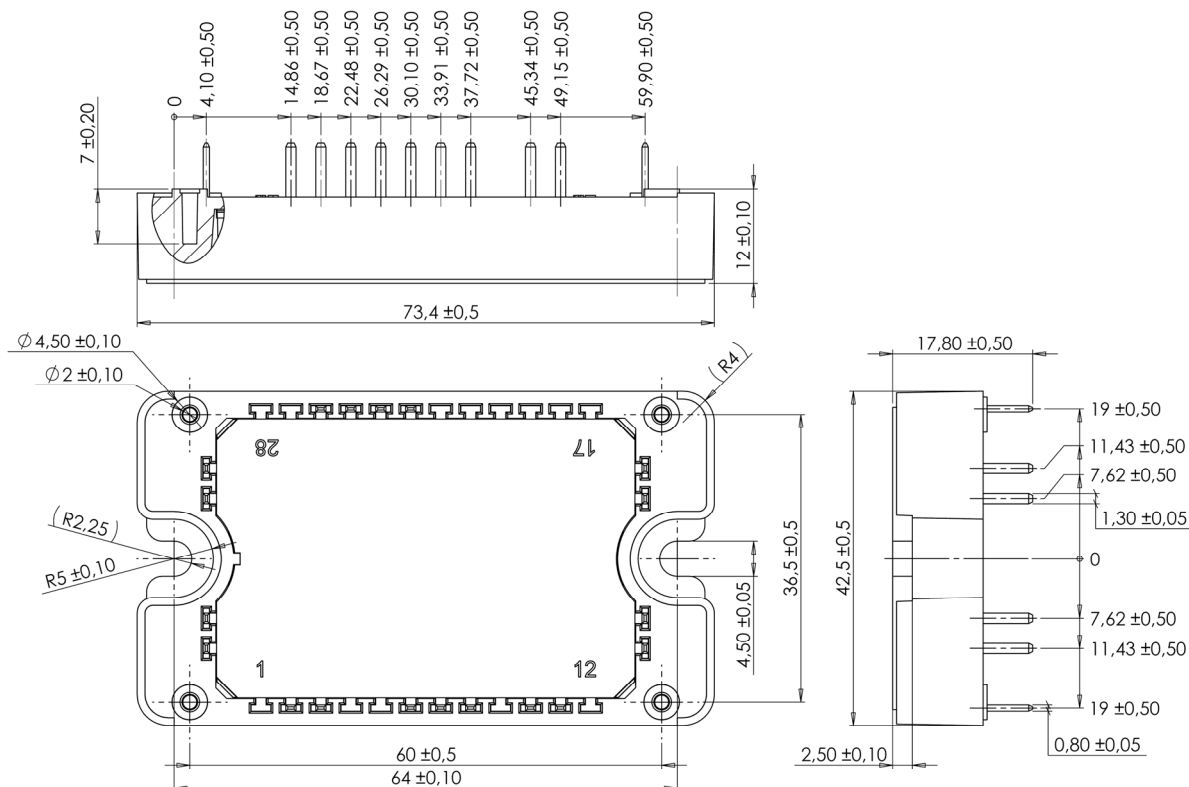
$$R_T = \frac{R_{25}}{\exp \left[B_{25/100} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$

T: Thermistor temperature
R_T: Thermistor value at T

5. Thermal and package characteristics

Symbol	Characteristic			Min	Max	Unit
V _{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000		V
T _J	Operating junction temperature range		SiC MOSFET	-40	150	°C
			SiC diode + IGBT	-40	175	
T _{JOP}	Recommended junction temperature under switching conditions			-40	T _{Jmax} -25	
T _{STG}	Storage Temperature Range			-40	125	
T _C	Operating Case Temperature			-40	125	
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

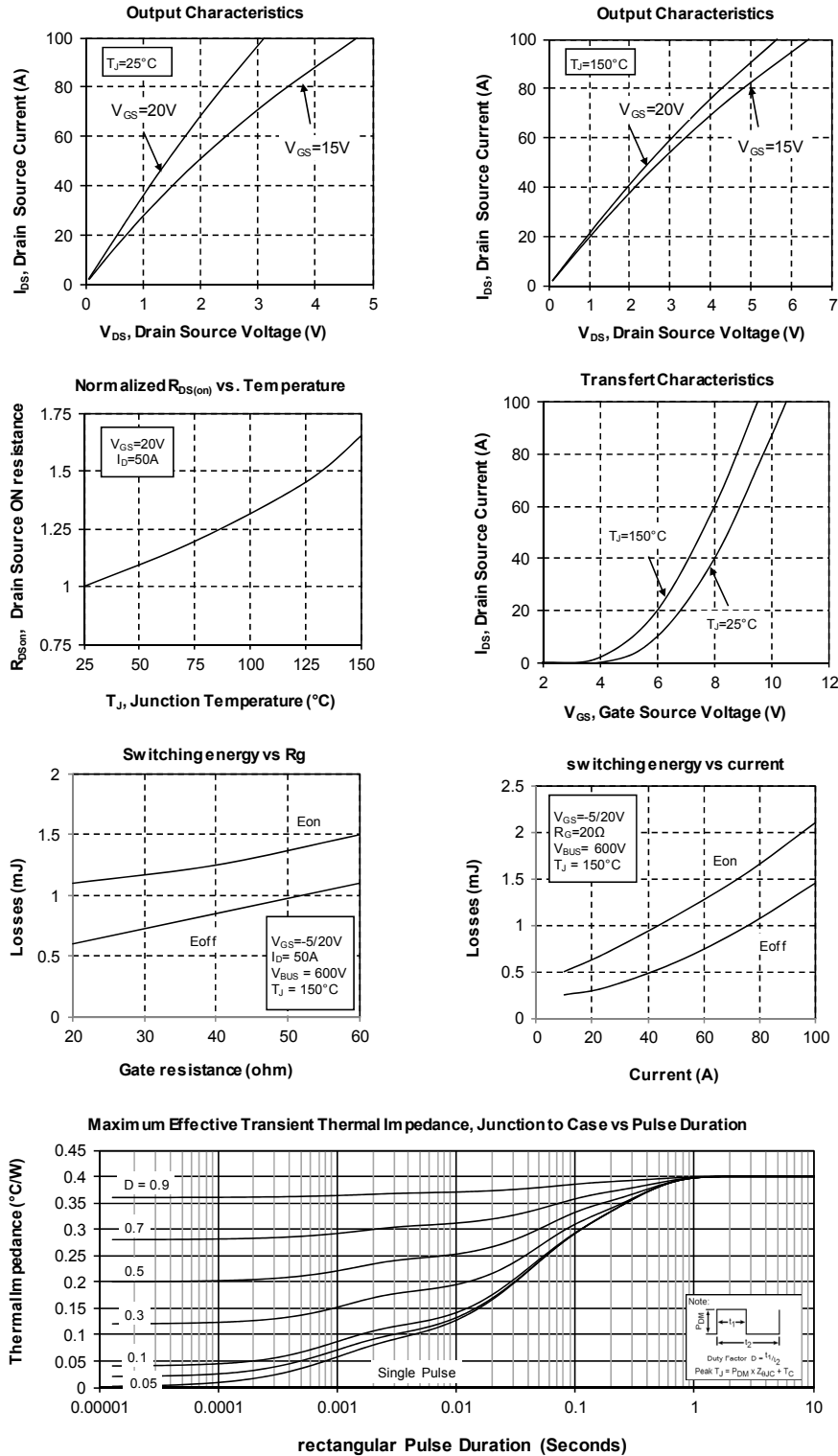
Package outline (dimensions in mm)

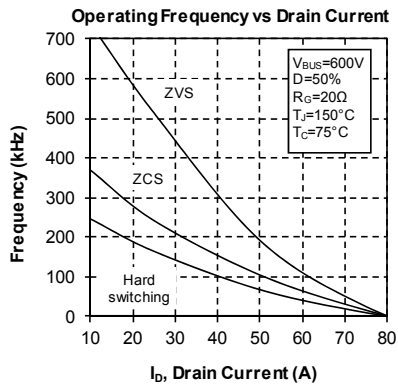
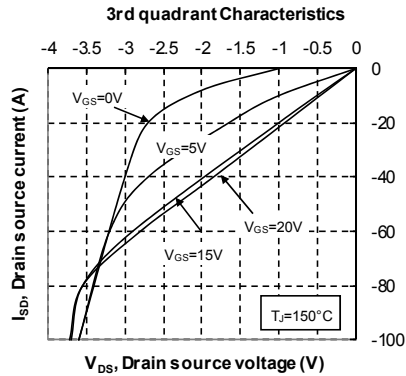
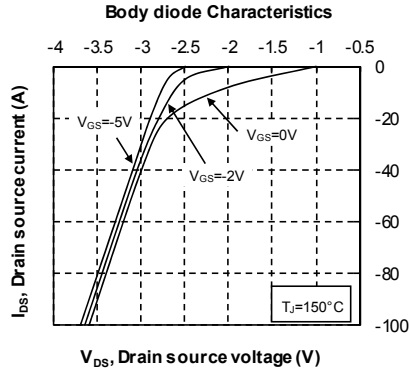
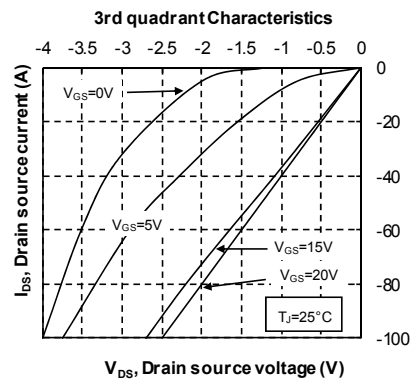
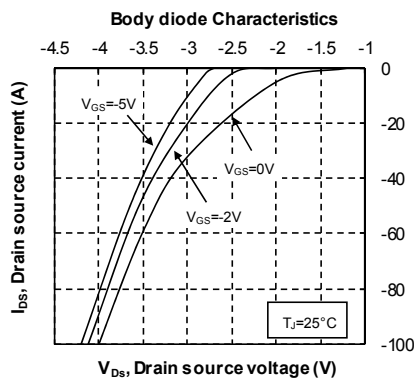
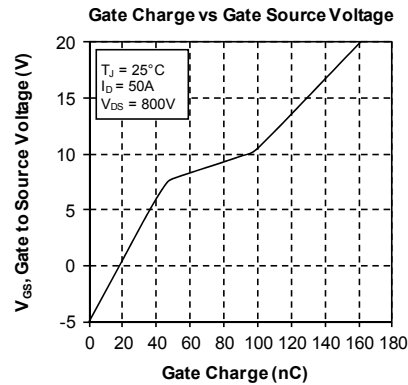
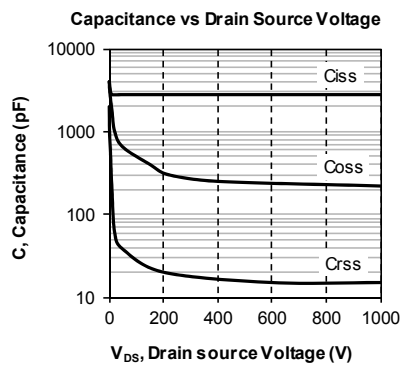


See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

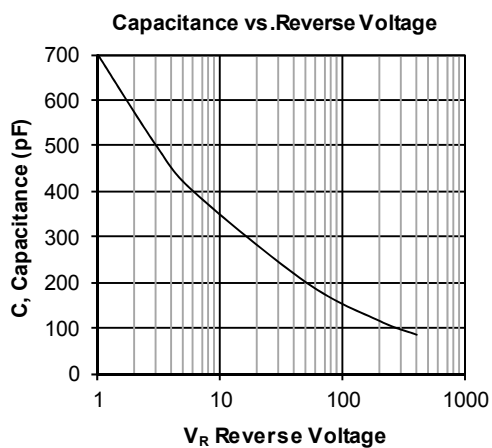
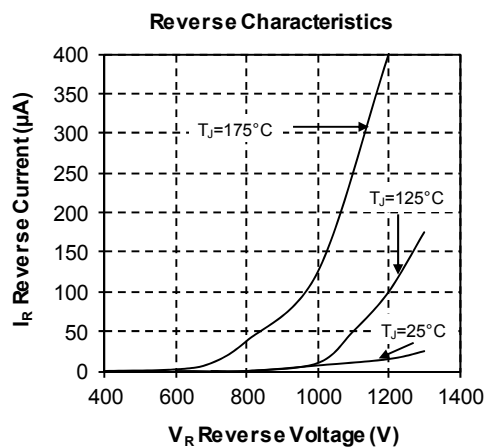
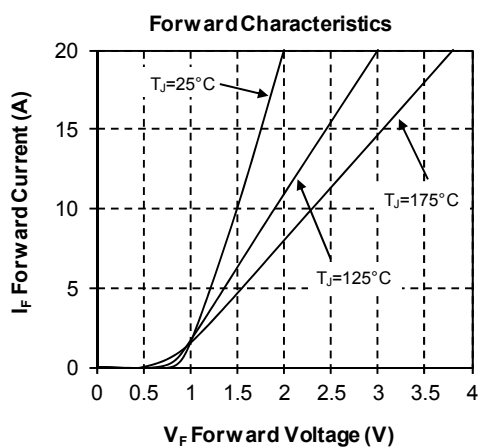
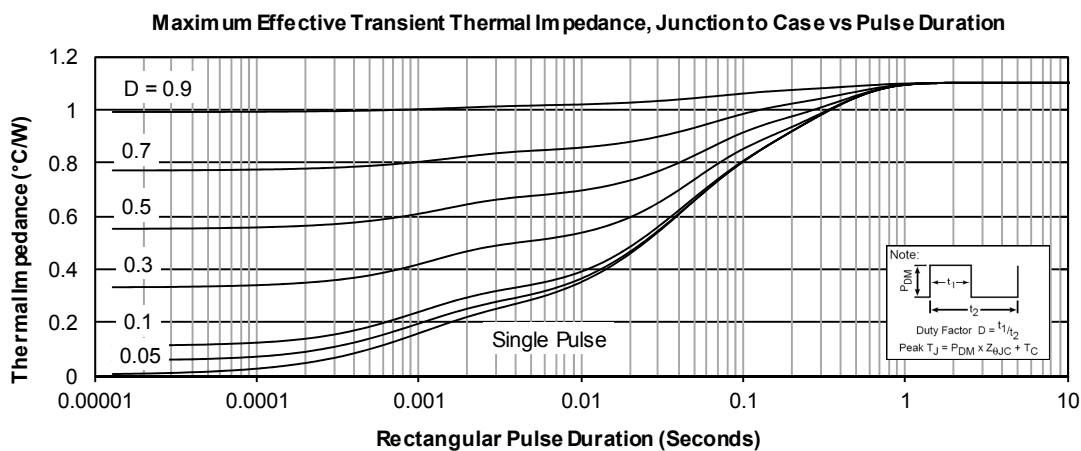
6. Typical performance curve

Q1, Q2 SiC MOSFET

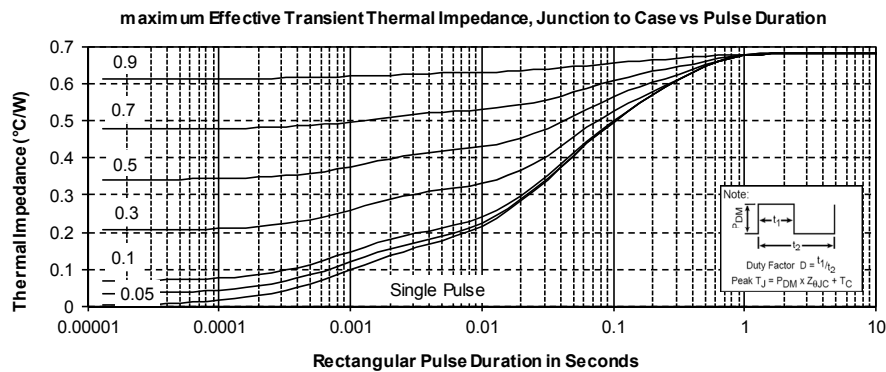
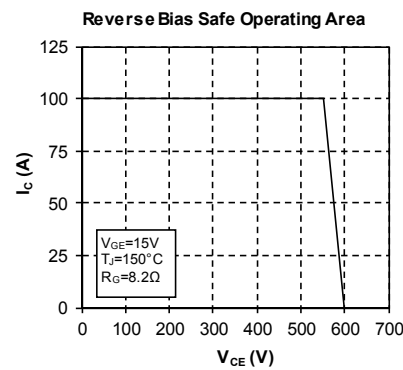
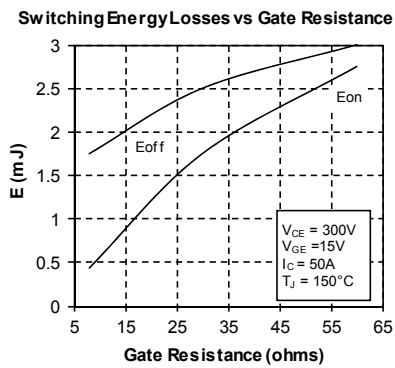
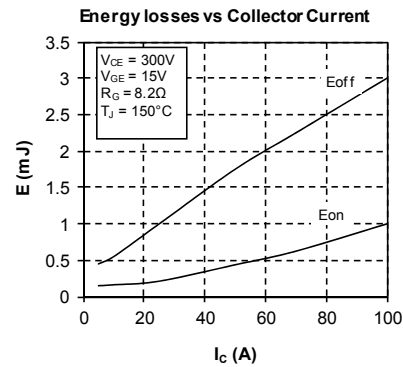
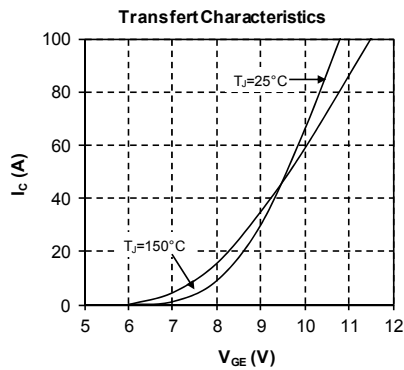
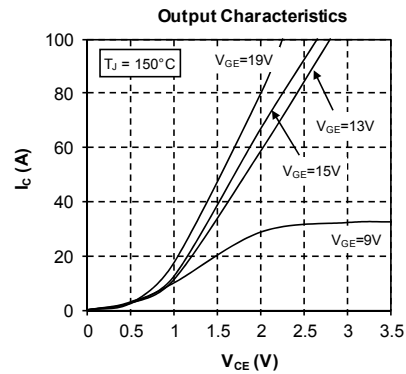
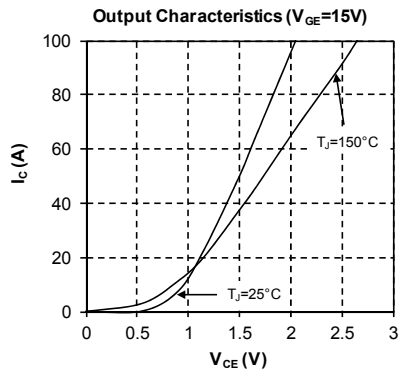




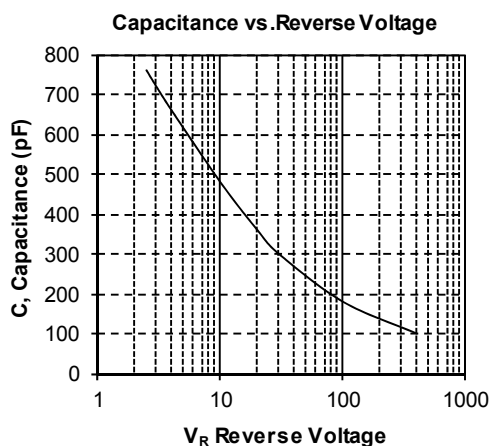
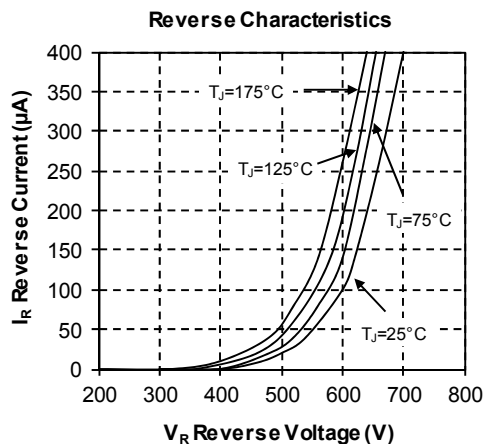
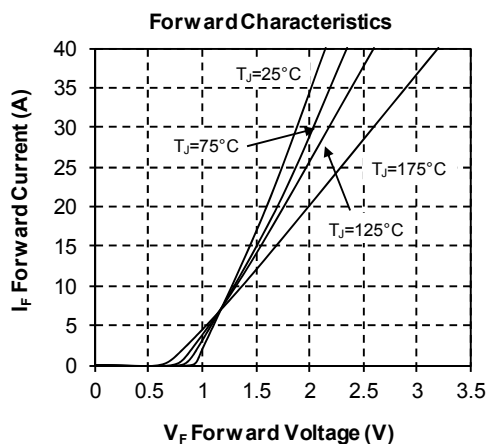
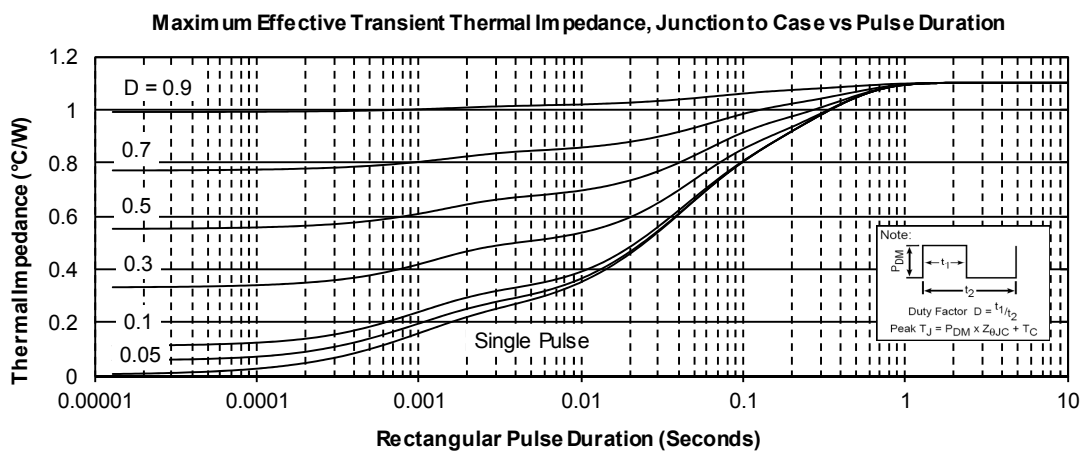
CR1 & CR2 SiC diode characteristics



Q3, Q4 Trench + field stop IGBT3



CR3 & CR4 SiC diode characteristics



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